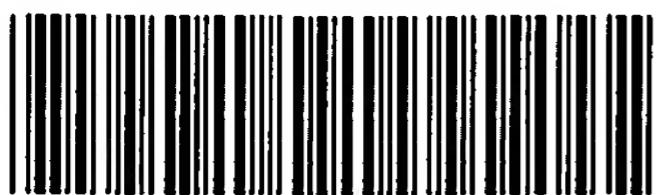


## **Search Notes**



**Application/Control No.**

10/646 142

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**Examiner**

Thuan D. Dang

**Applicant(s)/Patent under  
Reexamination**

RISCH ET AL.

## Art Unit

1764

**SEARCHED**

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner